

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/683,722	JIANG ET AL.
Examiner	Art Unit	
Thien D. Tran	2616	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	394	6/7/2006	TT
	389	6/7/2006	TT
	474	6/7/2006	TT